

# Single 2-Input AND Gate

## MC74VHC1G08, MC74VHC1GT08

The MC74VHC1G08 / MC74VHC1GT08 is a single 2 input AND gate in tiny footprint packages. The MC74VHC1G08 has CMOS-level input thresholds while the MC74VHC1GT08 has TTL-level input thresholds.

The input structures provide protection when voltages up to 5.5 V are applied, regardless of the supply voltage. This allows the device to be used to interface 5 V circuits to 3 V circuits. The output structures also provide protection when  $V_{CC} = 0$  V and when the output voltage exceeds  $V_{CC}$ . These input and output structures help prevent device destruction caused by supply voltage – input/output voltage mismatch, battery backup, hot insertion, etc.

### Features

- Designed for 2.0 V to 5.5 V  $V_{CC}$  Operation
- 3.5 ns  $t_{PD}$  at 5 V (typ)
- Inputs/Outputs Over-Voltage Tolerant up to 5.5 V
- $I_{OFF}$  Supports Partial Power Down Protection
- Source/Sink 8 mA at 3.0 V
- Available in SC-88A, SC-74A, TSOP-5, SOT-953 and UDFN6 Packages
- Chip Complexity < 100 FETs
- NLV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q100 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

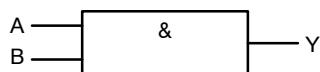
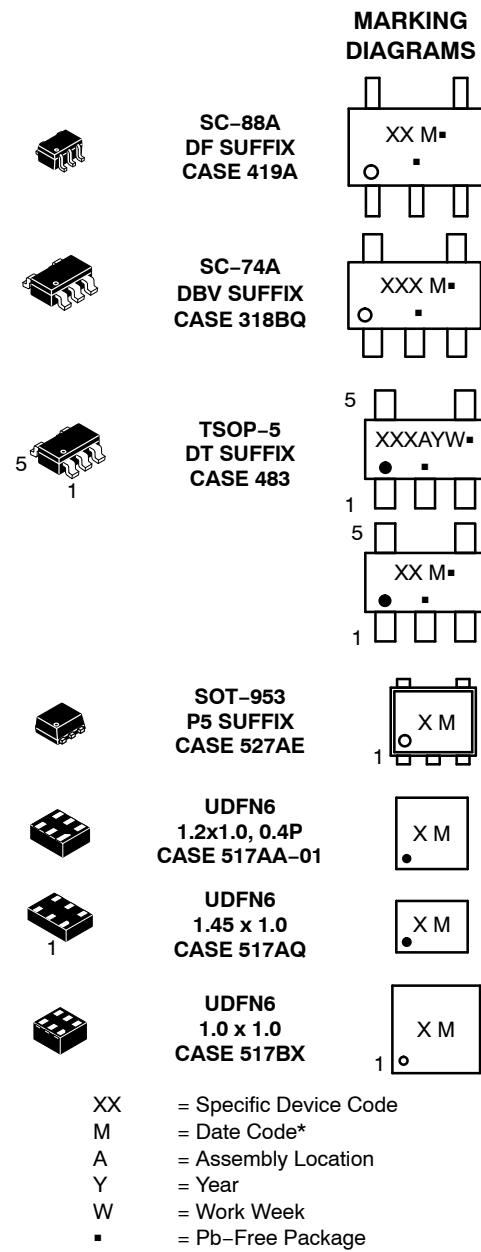


Figure 1. Logic Symbol



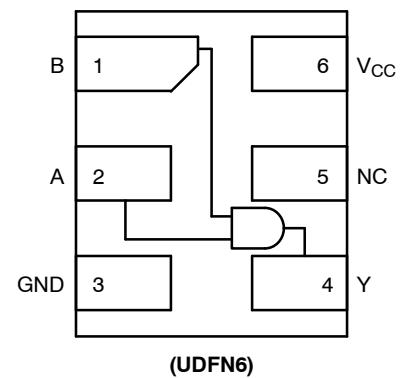
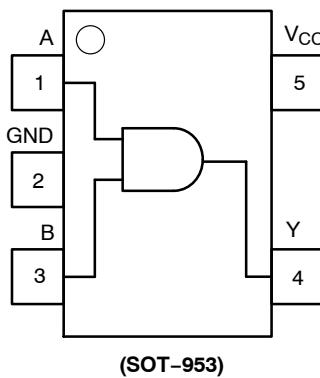
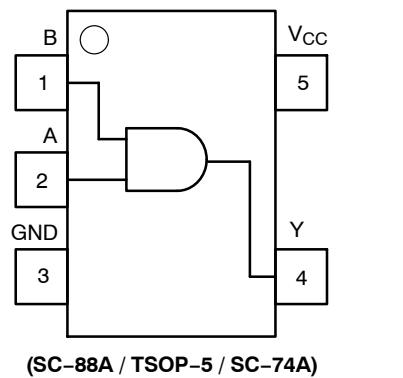
(Note: Microdot may be in either location)

\*Date Code orientation and/or position may vary depending upon manufacturing location.

### ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 7 of this data sheet.

## MC74VHC1G08, MC74VHC1GT08



**Figure 2. Pinout (Top View)**

### PIN ASSIGNMENT

(SC-88A / TSOP-5 / SC-74A)

Pin	Function
1	B
2	A
3	GND
4	Y
5	V <sub>CC</sub>

### PIN ASSIGNMENT (SOT-953)

Pin	Function
1	A
2	GND
3	B
4	Y
5	V <sub>CC</sub>

### PIN ASSIGNMENT (UDFN)

Pin	Function
1	B
2	A
3	GND
4	Y
5	NC
6	V <sub>CC</sub>

### FUNCTION TABLE

Input		Output
A	B	Y
L	L	L
L	H	L
H	L	L
H	H	H

# MC74VHC1G08, MC74VHC1GT08

## MAXIMUM RATINGS

Symbol	Characteristics	Value	Unit
V <sub>CC</sub>	DC Supply Voltage TSOP-5, SC-88A (NLV) SC-74A, SC-88A, UDFN6, SOT-953	-0.5 to +7.0 -0.5 to +6.5	V
V <sub>IN</sub>	DC Input Voltage TSOP-5, SC-88A (NLV) SC-74A, SC-88A, UDFN6, SOT-953	-0.5 to +7.0 -0.5 to +6.5	V
V <sub>OUT</sub>	DC Output Voltage TSOP-5, SC-88A (NLV) Active–Mode (High or Low State) Tri–State Mode (Note 1) Power–Down Mode (V <sub>CC</sub> = 0 V)	-0.5 to V <sub>CC</sub> + 0.5 -0.5 to +7.0 -0.5 to +7.0	V
	DC Output Voltage SC-74A, SC-88A, UDFN6, SOT-953 Active–Mode (High or Low State) Tri–State Mode (Note 1) Power–Down Mode (V <sub>CC</sub> = 0 V)	-0.5 to V <sub>CC</sub> + 0.5 -0.5 to +6.5 -0.5 to +6.5	V
I <sub>IK</sub>	DC Input Diode Current V <sub>IN</sub> < GND	-20	mA
I <sub>OK</sub>	DC Output Diode Current V <sub>OUT</sub> < GND	-20	mA
I <sub>OUT</sub>	DC Output Source/Sink Current	±25	mA
I <sub>CC</sub> or I <sub>GND</sub>	DC Supply Current per Supply Pin or Ground Pin	±50	mA
T <sub>STG</sub>	Storage Temperature Range	-65 to +150	°C
T <sub>L</sub>	Lead Temperature, 1 mm from Case for 10 secs	260	°C
T <sub>J</sub>	Junction Temperature Under Bias	+150	°C
θ <sub>JA</sub>	Thermal Resistance (Note 2)  SC-88A SC-74A SOT-953 UDFN6	377 320 254 154	°C/W
P <sub>D</sub>	Power Dissipation in Still Air  SC-88A SC-74A SOT-953 UDFN6	332 390 491 812	mW
MSL	Moisture Sensitivity	Level 1	—
F <sub>R</sub>	Flammability Rating  Oxygen Index: 28 to 34	UL 94 V-0 @ 0.125 in	—
V <sub>ESD</sub>	ESD Withstand Voltage (Note 3)  Human Body Model Charged Device Model	2000 1000	V
I <sub>Latchup</sub>	Latchup Performance (Note 4)	±100	mA

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- Applicable to devices with outputs that may be tri–stated.
- Measured with minimum pad spacing on an FR4 board, using 10mm–by–1inch, 2 ounce copper trace no air flow per JESD51–7.
- HBM tested to ANSI/ESDA/JEDEC JS-001-2017. CDM tested to EIA/JESD22-C101-F. JEDEC recommends that ESD qualification to EIA/JESD22-A115-A (Machine Model) be discontinued per JEDEC/JEP172A.
- Tested to EIA/JESD78 Class II.

# MC74VHC1G08, MC74VHC1GT08

## RECOMMENDED OPERATING CONDITIONS

Symbol	Characteristics	Min	Max	Unit
$V_{CC}$	Positive DC Supply Voltage	2.0	5.5	V
$V_{IN}$	DC Input Voltage	0	5.5	V
$V_{OUT}$	DC Output Voltage TSOP-5, SC-88A (NLV)	0	$V_{CC}$	V
	DC Output Voltage SC-74A, SC-88A, UDFN6, SOT-953 Active-Mode (High or Low State) Tri-State Mode (Note 1) Power-Down Mode ( $V_{CC} = 0$ V)	0 0 0	$V_{CC}$ 5.5 5.5	
$T_A$	Operating Temperature Range	-55	+125	°C
$t_r, t_f$	Input Rise and Fall Time TSOP-5, SC-88A (NLV) $V_{CC} = 3.0$ V to 3.6 V $V_{CC} = 4.5$ V to 5.5 V	0 0	100 20	ns/V
	Input Rise and Fall Time SC-74A, SC-88A, UDFN6, SOT-953 $V_{CC} = 2.0$ V $V_{CC} = 2.3$ V to 2.7 V $V_{CC} = 3.0$ V to 3.6 V $V_{CC} = 4.5$ V to 5.5 V	0 0 0 0	20 20 10 5	

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

## DC ELECTRICAL CHARACTERISTICS (MC74VHC1G08)

Symbol	Parameter	Test Conditions	$V_{CC}$ (V)	$T_A = 25^\circ\text{C}$			$-40^\circ\text{C} \leq T_A \leq 85^\circ\text{C}$		$-55^\circ\text{C} \leq T_A \leq 125^\circ\text{C}$		Unit
				Min	Typ	Max	Min	Max	Min	Max	
$V_{IH}$	High-Level Input Voltage		2.0	1.5	—	—	1.5	—	1.5	—	V
			3.0	2.1	—	—	2.1	—	2.1	—	
			4.5	3.15	—	—	3.15	—	3.15	—	
			5.5	3.85	—	—	3.85	—	3.85	—	
$V_{IL}$	Low-Level Input Voltage		2.0	—	—	0.5	—	0.5	—	0.5	V
			3.0	—	—	0.9	—	0.9	—	0.9	
			4.5	—	—	1.35	—	1.35	—	1.35	
			5.5	—	—	1.65	—	1.65	—	1.65	
$V_{OH}$	High-Level Output Voltage	$V_{IN} = V_{IH}$ or $V_{IL}$ $I_{OH} = -50$ $\mu\text{A}$ $I_{OH} = -50$ $\mu\text{A}$ $I_{OH} = -50$ $\mu\text{A}$ $I_{OH} = -4$ mA $I_{OH} = -8$ mA	2.0	1.9	2.0	—	1.9	—	1.9	—	V
			3.0	2.9	3.0	—	2.9	—	2.9	—	
			4.5	4.4	4.5	—	4.4	—	4.4	—	
			3.0	2.58	—	—	2.48	—	2.34	—	
			4.5	3.94	—	—	3.80	—	3.66	—	
			2.0	—	0.0	0.1	—	0.1	—	0.1	
$V_{OL}$	Low-Level Output Voltage	$V_{IN} = V_{IH}$ or $V_{IL}$ $I_{OL} = 50$ $\mu\text{A}$ $I_{OL} = 50$ $\mu\text{A}$ $I_{OL} = 50$ $\mu\text{A}$ $I_{OL} = 4$ mA $I_{OL} = 8$ mA	3.0	—	0.0	0.1	—	0.1	—	0.1	V
			4.5	—	0.0	0.1	—	0.1	—	0.1	
			3.0	—	0.0	0.1	—	0.1	—	0.1	
			4.5	—	—	0.36	—	0.44	—	0.52	
			4.5	—	—	0.36	—	0.44	—	0.52	
$I_{IN}$	Input Leakage Current	$V_{IN} = 5.5$ V or GND	2.0 to 5.5	—	—	$\pm 0.1$	—	$\pm 1.0$	—	$\pm 1.0$	$\mu\text{A}$
$I_{OFF}$	Power Off Leakage Current	$V_{IN} = 5.5$ V or $V_{OUT} = 5.5$ V	0	—	—	1.0	—	10	—	10	$\mu\text{A}$
$I_{CC}$	Quiescent Supply Current	$V_{IN} = V_{CC}$ or GND	5.5	—	—	1.0	—	20	—	40	$\mu\text{A}$

# MC74VHC1G08, MC74VHC1GT08

## DC ELECTRICAL CHARACTERISTICS (MC74VHC1GT08)

Symbol	Parameter	Test Conditions	V <sub>CC</sub> (V)	T <sub>A</sub> = 25°C			−40°C ≤ T <sub>A</sub> ≤ 85°C		−55°C ≤ T <sub>A</sub> ≤ 125°C		Unit
				Min	Typ	Max	Min	Max	Min	Max	
V <sub>IH</sub>	High-Level Input Voltage		2.0	1.0	—	—	1.0	—	1.0	—	V
			3.0	1.4	—	—	1.4	—	1.4	—	
			4.5	2.0	—	—	2.0	—	2.0	—	
			5.5	2.0	—	—	2.0	—	2.0	—	
V <sub>IL</sub>	Low-Level Input Voltage		2.0	—	—	0.28	—	0.28	—	0.28	V
			3.0	—	—	0.45	—	0.45	—	0.45	
			4.5	—	—	0.8	—	0.8	—	0.8	
			5.5	—	—	0.8	—	0.8	—	0.8	
V <sub>OH</sub>	High-Level Output Voltage	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub> I <sub>OH</sub> = −50 μA I <sub>OH</sub> = −50 μA I <sub>OH</sub> = −50 μA I <sub>OH</sub> = −4 mA I <sub>OH</sub> = −8 mA	2.0	1.9	2.0	—	1.9	—	1.9	—	V
			3.0	2.9	3.0	—	2.9	—	2.9	—	
			4.5	4.4	4.5	—	4.4	—	4.4	—	
			3.0	2.58	—	—	2.48	—	2.34	—	
			4.5	3.94	—	—	3.80	—	3.66	—	
			2.0	—	0.0	0.1	—	0.1	—	0.1	
V <sub>OL</sub>	Low-Level Output Voltage	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub> I <sub>OL</sub> = 50 μA I <sub>OL</sub> = 50 μA I <sub>OL</sub> = 50 μA I <sub>OL</sub> = 4 mA I <sub>OL</sub> = 8 mA	3.0	—	0.0	0.1	—	0.1	—	0.1	V
			4.5	—	0.0	0.1	—	0.1	—	0.1	
			4.5	—	0.0	0.1	—	0.1	—	0.1	
			3.0	—	—	0.36	—	0.44	—	0.52	
			4.5	—	—	0.36	—	0.44	—	0.52	
			2.0	—	0.0	0.1	—	0.1	—	0.1	
I <sub>IN</sub>	Input Leakage Current	V <sub>IN</sub> = 5.5 V or GND	2.0 to 5.5	—	—	±0.1	—	±1.0	—	±1.0	μA
I <sub>OFF</sub>	Power Off Leakage Current	V <sub>IN</sub> = 5.5 V or V <sub>OUT</sub> = 5.5 V	0	—	—	1.0	—	10	—	10	μA
I <sub>CC</sub>	Quiescent Supply Current	V <sub>IN</sub> = V <sub>CC</sub> or GND	5.5	—	—	1.0	—	20	—	40	μA
I <sub>CC</sub> T	Increase in Quiescent Supply Current per Input Pin	One Input: V <sub>IN</sub> = 3.4 V; Other Input at V <sub>CC</sub> or GND	5.5	—	—	1.35	—	1.5	—	1.65	mA

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

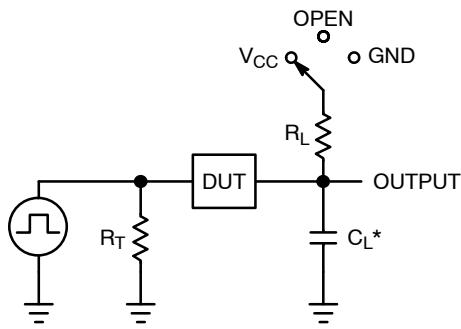
## AC ELECTRICAL CHARACTERISTICS

Symbol	Parameter	Conditions	V <sub>CC</sub> (V)	T <sub>A</sub> = 25°C			−40°C ≤ T <sub>A</sub> ≤ 85°C		−55°C ≤ T <sub>A</sub> ≤ 125°C		Unit
				Min	Typ	Max	Min	Max	Min	Max	
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation Delay, A to Y (Figures 3 and 4)	C <sub>L</sub> = 15 pF	3.0 to 3.6	—	4.1	8.8	—	10.5	—	12.5	ns
				—	5.9	12.3	—	14.0	—	16.5	
		C <sub>L</sub> = 15 pF	4.5 to 5.5	—	3.5	5.9	—	7.0	—	9.0	
		C <sub>L</sub> = 50 pF		—	4.2	7.9	—	9.0	—	11.0	
C <sub>IN</sub>	Input Capacitance			—	4.0	10	—	10	—	10	pF
C <sub>OUT</sub>	Output Capacitance	Output in High Impedance State		—	6.0	—	—	—	—	—	pF

C <sub>PD</sub>	Power Dissipation Capacitance (Note 5)	Typical @ 25°C, V <sub>CC</sub> = 5.0 V				pF
		8.0				

5. C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation: I<sub>CC(OPR)</sub> = C<sub>PD</sub> • V<sub>CC</sub> • f<sub>in</sub> + I<sub>CC</sub>. C<sub>PD</sub> is used to determine the no-load dynamic power consumption; P<sub>D</sub> = C<sub>PD</sub> • V<sub>CC</sub><sup>2</sup> • f<sub>in</sub> + I<sub>CC</sub> • V<sub>CC</sub>.

## MC74VHC1G08, MC74VHC1GT08



Test	Switch Position	$C_L$ , pF	$R_L$ , $\Omega$
$t_{PLH} / t_{PHL}$	Open	See AC Characteristics Table	X
$t_{PLZ} / t_{PZL}$	$V_{CC}$		1 k
$t_{PHZ} / t_{PZH}$	GND		1 k

X = Don't Care

Figure 3. Test Circuit

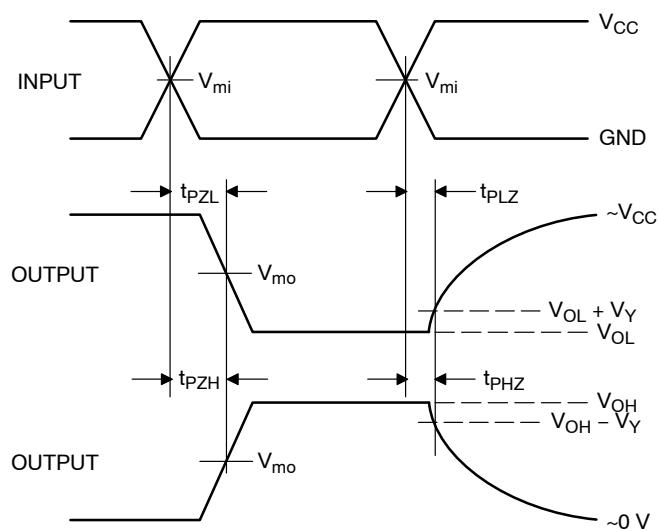
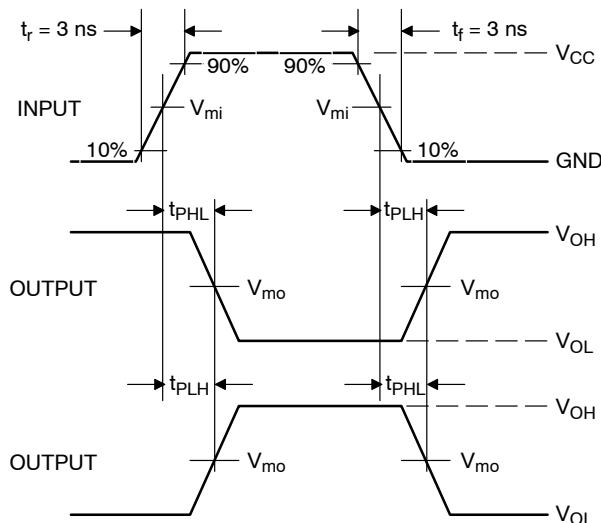


Figure 4. Switching Waveforms

$V_{CC}$ , V	$V_{mi}$ , V	$V_{mo}$ , V		$V_Y$ , V
		$t_{PLH}, t_{PHL}$	$t_{PZL}, t_{PLZ}, t_{PZH}, t_{PHZ}$	
3.0 to 3.6	$V_{CC}/2$	$V_{CC}/2$	$V_{CC}/2$	0.3
4.5 to 5.5	$V_{CC}/2$	$V_{CC}/2$	$V_{CC}/2$	0.3

# MC74VHC1G08, MC74VHC1GT08

## ORDERING INFORMATION

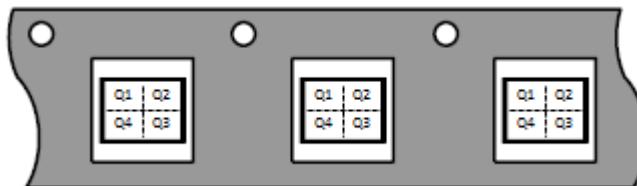
Device	Packages	Specific Device Code	Pin 1 Orientation (See below)	Shipping <sup>†</sup>
MC74VHC1G08DFT1G	SC-88A	V2	Q2	3000 / Tape & Reel
MC74VHC1G08DFT2G	SC-88A	V2	Q4	3000 / Tape & Reel
NLVVHC1G08DFT1G*	SC-88A	V2	Q2	3000 / Tape & Reel
NLVVHC1G08DFT2G*	SC-88A	V2	Q4	3000 / Tape & Reel
M74VHC1GT08DFT1G	SC-88A	VT	Q2	3000 / Tape & Reel
M74VHC1GT08DFT2G	SC-88A	VT	Q4	3000 / Tape & Reel
NLVVHC1GT08DFT1G*	SC-88A	VT	Q2	3000 / Tape & Reel
NLVVHC1GT08DFT2G*	SC-88A	VT	Q4	3000 / Tape & Reel
MC74VHC1G08DBVT1G	SC-74A	V2	Q4	3000 / Tape & Reel
MC74VHC1GT08DBVT1G	SC-74A	VT	Q4	3000 / Tape & Reel
MC74VHC1G08DTT1G	TSOP-5	V2	Q4	3000 / Tape & Reel
M74VHC1GT08DTT1G	TSOP-5	VT	Q4	3000 / Tape & Reel
NLV74VHC1G08DTT1G*	TSOP-5	V2	Q4	3000 / Tape & Reel
NLVVHC1GT08DTT1G*	TSOP-5	VT	Q4	3000 / Tape & Reel
MC74VHC1G08P5T5G	SOT-953	E	Q2	8000 / Tape & Reel
MC74VHC1GT08P5T5G	SOT-953	P	Q2	8000 / Tape & Reel
MC74VHC1G08MU1TCG	UDFN6, 1.45 x 1.0, 0.5P	K (Rotated 180° CW)	Q4	3000 / Tape & Reel
MC74VHC1GT08MU1TCG	UDFN6, 1.45 x 1.0, 0.5P	4 (Rotated 270° CW)	Q4	3000 / Tape & Reel
MC74VHC1G08MU2TCG	UDFN6, 1.2 x 1.0, 0.4P	2	Q4	3000 / Tape & Reel
MC74VHC1G08MU3TCG	UDFN6, 1.0 x 1.0, 0.35	D (Rotated 270° CW)	Q4	3000 / Tape & Reel
MC74VHC1GT08MU3TCG	UDFN6, 1.0 x 1.0, 0.35	K	Q4	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

\*NLV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q100 Qualified and PPAP Capable.

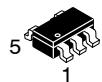
### Pin 1 Orientation in Tape and Reel

#### Direction of Feed

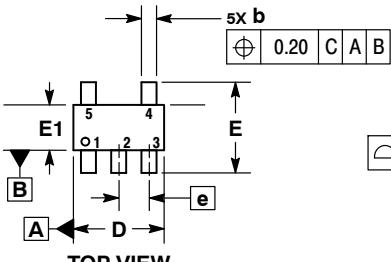


# MECHANICAL CASE OUTLINE

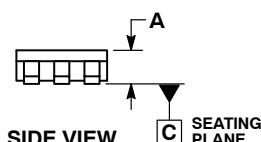
## PACKAGE DIMENSIONS



SCALE 2:1



TOP VIEW



SIDE VIEW C SEATING PLANE

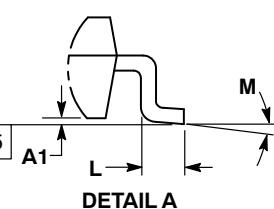
**SC-74A**  
CASE 318BQ  
ISSUE B

DATE 18 JAN 2018

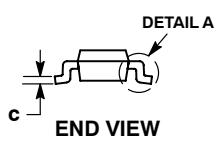
NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.
4. DIMENSIONS A AND B DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.15 PER SIDE.

DIM	MILLIMETERS	
	MIN	MAX
A	0.90	1.10
A1	0.01	0.10
b	0.25	0.50
c	0.10	0.26
D	2.85	3.15
E	2.50	3.00
E1	1.35	1.65
e	0.95 BSC	
L	0.20	0.60
M	0 °	10 °

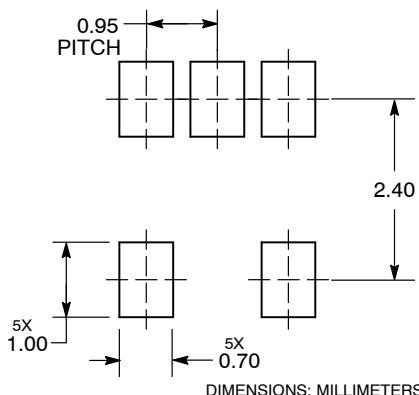


DETAIL A



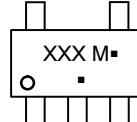
C END VIEW

**RECOMMENDED  
SOLDERING FOOTPRINT\***



DIMENSIONS: MILLIMETERS

**GENERIC  
MARKING DIAGRAM\***



XXX = Specific Device Code

M = Date Code

- = Pb-Free Package

(Note: Microdot may be in either location)

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

# MECHANICAL CASE OUTLINE

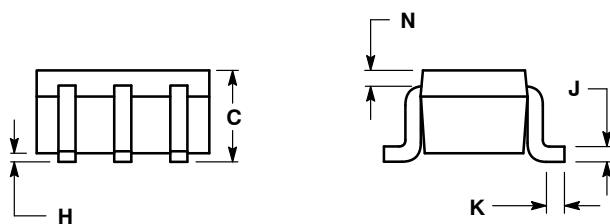
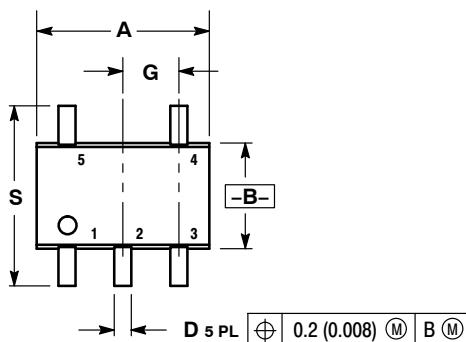
## PACKAGE DIMENSIONS



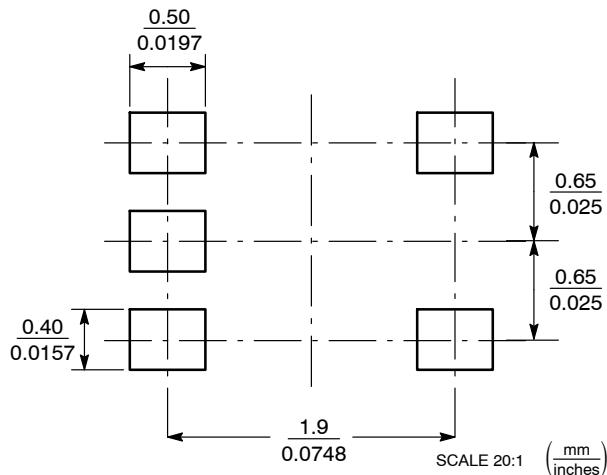
SCALE 2:1

**SC-88A (SC-70-5/SOT-353)**  
CASE 419A-02  
ISSUE L

DATE 17 JAN 2013



SOLDER FOOTPRINT



STYLE 1:

- PIN 1. BASE
- 2. Emitter
- 3. BASE
- 4. COLLECTOR
- 5. COLLECTOR

STYLE 6:

- PIN 1. Emitter 2
- 2. BASE 2
- 3. Emitter 1
- 4. COLLECTOR
- 5. COLLECTOR 2/BASE 1

STYLE 2:

- PIN 1. ANODE
- 2. Emitter
- 3. BASE
- 4. COLLECTOR
- 5. CATHODE

STYLE 7:

- PIN 1. BASE
- 2. Emitter
- 3. BASE
- 4. COLLECTOR
- 5. COLLECTOR

STYLE 3:

- PIN 1. ANODE 1
- 2. N/C
- 3. ANODE 2
- 4. CATHODE 2
- 5. CATHODE 1

STYLE 8:

- PIN 1. CATHODE
- 2. COLLECTOR
- 3. N/C
- 4. BASE
- 5. Emitter

STYLE 4:

- PIN 1. SOURCE 1
- 2. DRAIN 1/2
- 3. SOURCE 1
- 4. GATE 1
- 5. GATE 2

STYLE 9:

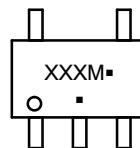
- PIN 1. ANODE
- 2. CATHODE
- 3. ANODE
- 4. ANODE
- 5. ANODE

NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.
3. 419A-01 OBSOLETE. NEW STANDARD 419A-02.
4. DIMENSIONS A AND B DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.071	0.087	1.80	2.20
B	0.045	0.053	1.15	1.35
C	0.031	0.043	0.80	1.10
D	0.004	0.012	0.10	0.30
G	0.026	BSC	0.65	BSC
H	---	0.004	---	0.10
J	0.004	0.010	0.10	0.25
K	0.004	0.012	0.10	0.30
N	0.008	REF	0.20	REF
S	0.079	0.087	2.00	2.20

GENERIC MARKING  
DIAGRAM\*



XXX = Specific Device Code

M = Date Code

■ = Pb-Free Package

(Note: Microdot may be in either location)

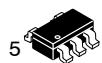
\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

- STYLE 5:  
PIN 1. CATHODE  
2. COMMON ANODE  
3. CATHODE 2  
4. CATHODE 3  
5. CATHODE 4

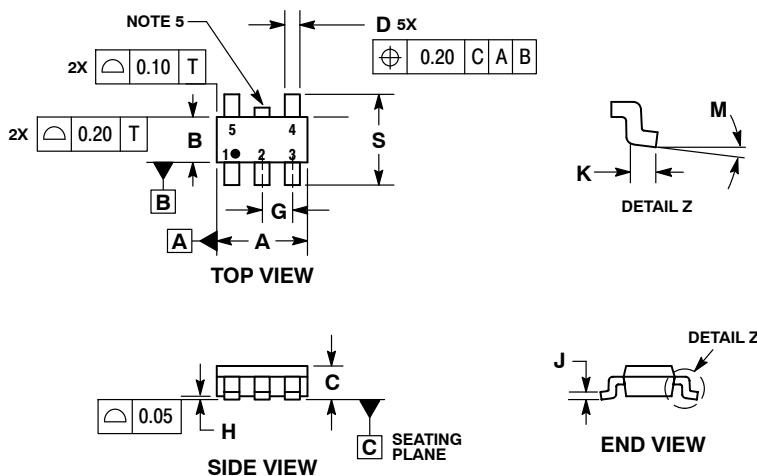
Note: Please refer to datasheet for style callout. If style type is not called out in the datasheet refer to the device datasheet pinout or pin assignment.

# MECHANICAL CASE OUTLINE

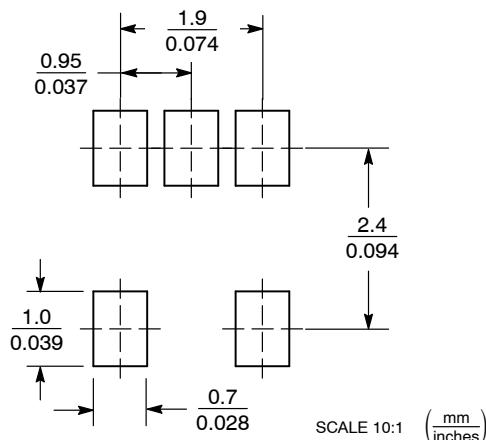
## PACKAGE DIMENSIONS



SCALE 2:1



### SOLDERING FOOTPRINT\*



SCALE 10:1 ( $\frac{\text{mm}}{\text{inches}}$ )

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

**TSOP-5**  
CASE 483  
ISSUE N

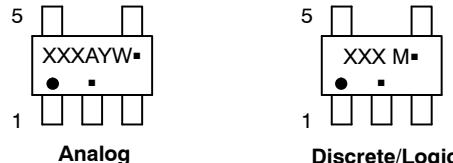
DATE 12 AUG 2020

### NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.
4. DIMENSIONS A AND B DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.15 PER SIDE. DIMENSION A.
5. OPTIONAL CONSTRUCTION: AN ADDITIONAL TRIMMED LEAD IS ALLOWED IN THIS LOCATION. TRIMMED LEAD NOT TO EXTEND MORE THAN 0.2 FROM BODY.

DIM	MILLIMETERS	
	MIN	MAX
A	2.85	3.15
B	1.35	1.65
C	0.90	1.10
D	0.25	0.50
G	0.95 BSC	
H	0.01	0.10
J	0.10	0.26
K	0.20	0.60
M	0°	10°
S	2.50	3.00

### GENERIC MARKING DIAGRAM\*



XXX = Specific Device Code    XXX = Specific Device Code

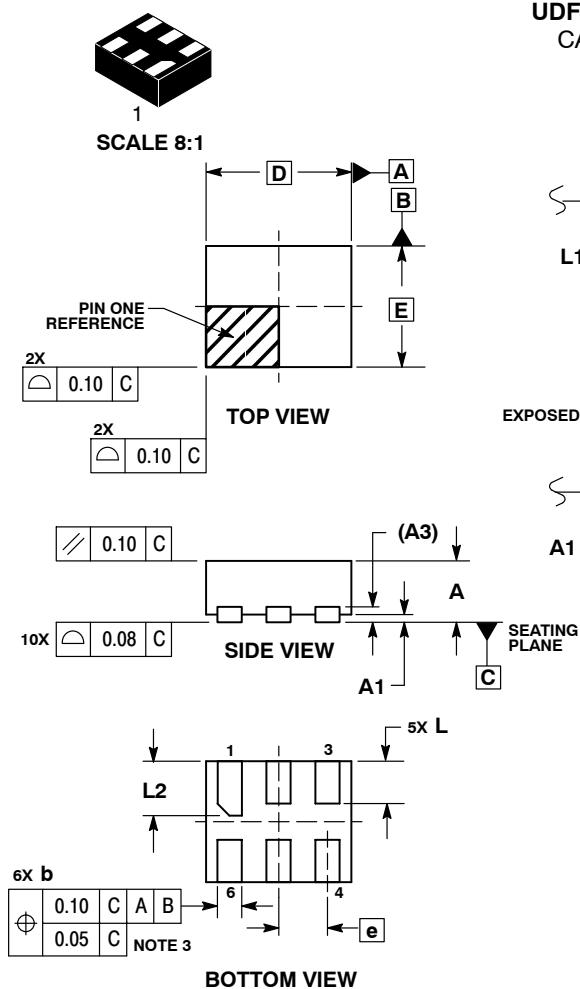
A = Assembly Location    M = Date Code  
Y = Year    ▪ = Pb-Free Package  
W = Work Week  
▪ = Pb-Free Package

(Note: Microdot may be in either location)

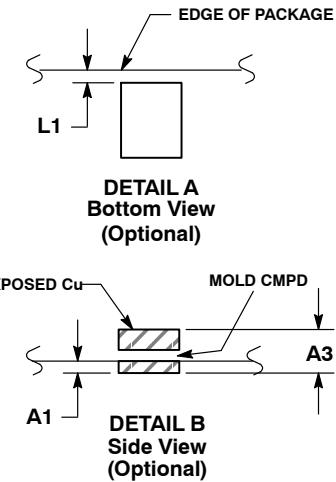
\*This information is generic. Please refer to device data sheet for actual part marking.  
Pb-Free indicator, "G" or microdot "▪", may or may not be present.

# MECHANICAL CASE OUTLINE

## PACKAGE DIMENSIONS



**UDFN6, 1.2x1.0, 0.4P  
CASE 517AA-01  
ISSUE D**



**NOTES:**

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS.
- 3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.25 AND 0.30 mm FROM TERMINAL.
- 4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

DIM	MIN	MAX
A	0.45	0.55
A1	0.00	0.05
A3	0.127 REF	
b	0.15	0.25
D	1.20 BSC	
E	1.00 BSC	
e	0.40 BSC	
L	0.30	0.40
L1	0.00	0.15
L2	0.40	0.50

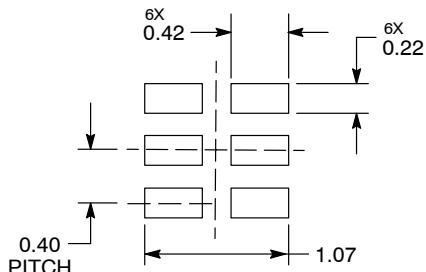
### GENERIC MARKING DIAGRAM\*



X = Specific Device Code  
M = Date Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present.

### MOUNTING FOOTPRINT\*



DIMENSIONS: MILLIMETERS

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

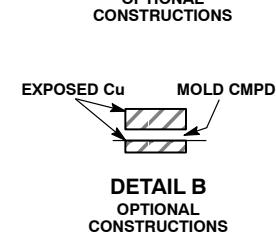
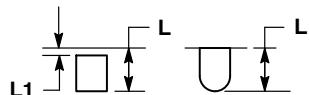
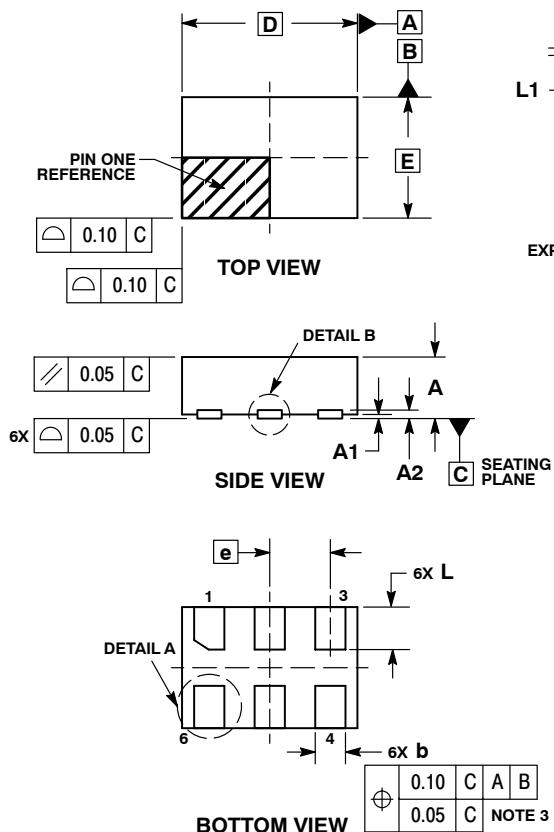
# MECHANICAL CASE OUTLINE

## PACKAGE DIMENSIONS



UDFN6, 1.45x1.0, 0.5P  
CASE 517AQ  
ISSUE O

DATE 15 MAY 2008

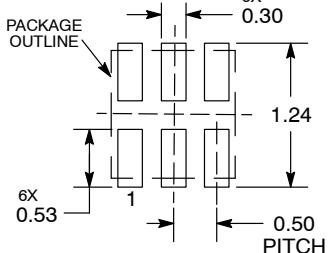


### NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSION  $b$  APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30 mm FROM THE TERMINAL TIP.

MILLIMETERS		
DIM	MIN	MAX
A	0.45	0.55
A1	0.00	0.05
A2	0.07	REF
b	0.20	0.30
D	1.45	BSC
E	1.00	BSC
e	0.50	BSC
L	0.30	0.40
L1	---	0.15

### MOUNTING FOOTPRINT



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

### GENERIC MARKING DIAGRAM\*



X = Specific Device Code  
M = Date Code

\*This information is generic. Please refer to device data sheet for actual part marking.  
Pb-Free indicator, "G" or microdot "■", may or may not be present.

# MECHANICAL CASE OUTLINE

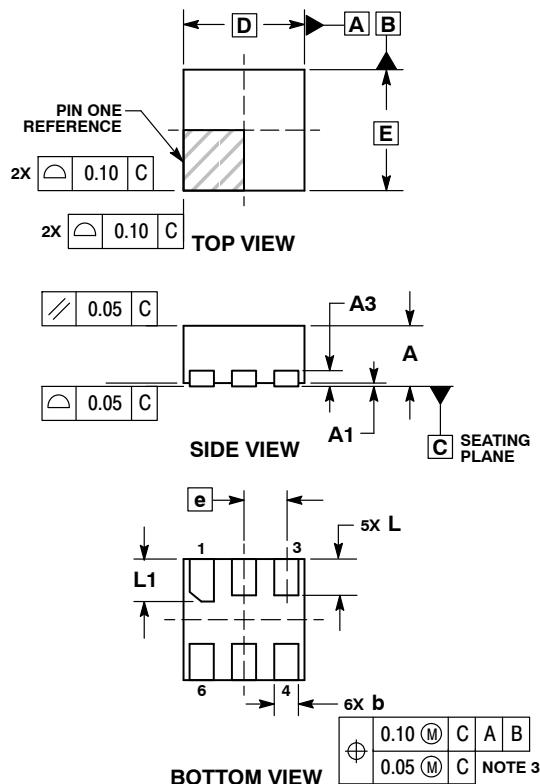
## PACKAGE DIMENSIONS



SCALE 4:1

**UDFN6, 1x1, 0.35P**  
CASE 517BX  
ISSUE O

DATE 18 MAY 2011

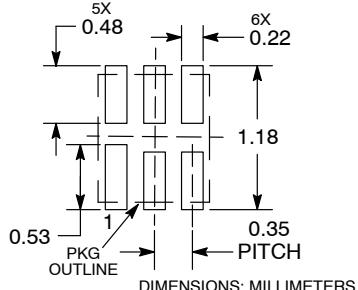


NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.20 MM FROM TERMINAL TIP.
4. PACKAGE DIMENSIONS EXCLUSIVE OF BURRS AND MOLD FLASH.

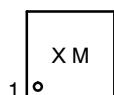
DIM	MILLIMETERS	
	MIN	MAX
A	0.45	0.55
A1	0.00	0.05
A3	0.13	REF
b	0.12	0.22
D	1.00	BSC
E	1.00	BSC
e	0.35	BSC
L	0.25	0.35
L1	0.30	0.40

**RECOMMENDED  
SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

**GENERIC  
MARKING DIAGRAM\***



X = Specific Device Code  
M = Date Code

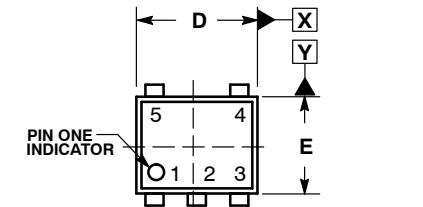
\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

# MECHANICAL CASE OUTLINE

## PACKAGE DIMENSIONS



SCALE 4:1



TOP VIEW

SOT-953  
CASE 527AE  
ISSUE E

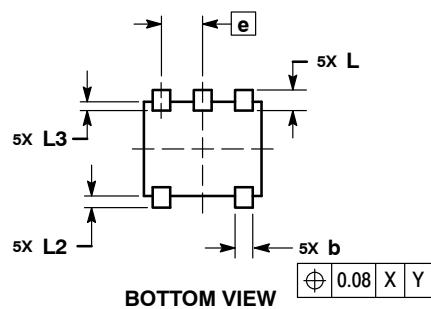
DATE 02 AUG 2011

NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS
3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF THE BASE MATERIAL.
4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

DIM	MILLIMETERS		
	MIN	NOM	MAX
A	0.34	0.37	0.40
b	0.10	0.15	0.20
C	0.07	0.12	0.17
D	0.95	1.00	1.05
E	0.75	0.80	0.85
e	0.35	BSC	
H <sub>E</sub>	0.95	1.00	1.05
L	0.175	REF	
L <sub>2</sub>	0.05	0.10	0.15
L <sub>3</sub>	---	---	0.15

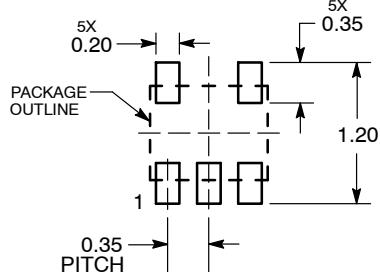
SIDE VIEW



BOTTOM VIEW

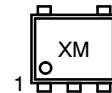
$\oplus 0.08$  X Y

SOLDERING FOOTPRINT\*



DIMENSIONS: MILLIMETERS

GENERIC  
MARKING DIAGRAM\*



X = Specific Device Code  
M = Month Code

\*This information is generic. Please refer to device data sheet for actual part marking.  
Pb-Free indicator, "G" or microdot "■", may or may not be present.

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